

FORM PTO-1449 U.S. Department of Commerce Patent and Trademark Office List of Documents Cited by Applicant	Application No.:	10/615,842
	Filing Date:	July 10, 2003
	First Named Inventor:	Soojin Oh
	Group:	1753
	Examiner:	Phasge, Arun S.
Attorney Docket No.:		421/170/8/2 CIP

U.S. PATENT DOCUMENTS

Examiner Initial	Cite No.	Document Number	Publication Date	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, where relevant passages or relevant figures appear

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Examiner Initials	Cite No.	Document Number (country code, no., kind code (if known))	Publication Date	Name of Patentee or Applicant	Pages, columns, lines where relevant passages appear	T

OTHER DOCUMENTS

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<i>Ad</i>	1.	International Preliminary Report for PCT/US2004/020150 dated April 6, 2006.	

EXAMINER

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DATE CONSIDERED

1/17/07

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FORM PTO-849 U.S. Department of Commerce
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ASG	1.	2003/0102222	06/05/2003	Zhou et al.	

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Application Number	10/615,842
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Examiner Name	Brian L. Mutschler
Attorney Docket Number	032566-066

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Examiner Initials	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.
del	A. M. AFFOUNE et al., "Electrophoretic Deposition of Nanosized Diamond Particles", <i>Langmuir</i> , Vol. 17, No. 2, 2001. pp. 547-551.

**Examiner
Signature**

Date
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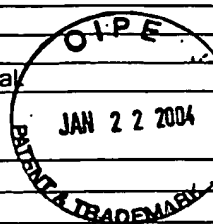
FIRST INFORMATION DISCLOSURE STATEMENT BY APPLICANT

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Sheet 1 of 1

Complete if Known

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 Examiner Name Unassigned
 Attorney Docket Number 032566-066

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					Yes	No
						</

NON-PATENT LITERATURE DOCUMENTS

Examiner Initials	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.
RSP	Bower, Chris et al., "Plasma-induced alignment of carbon nanotubes", Applied Physics Letters, Vol. 77, No., 6, Pages 830-832; August 7, 2000.
RSP	Journet, C. et al., "Large-scale production single-walled carbon nanotubes by electric-arc technique", Nature, Vol. 388, pages 757-760; August 1997.

Examiner Signature

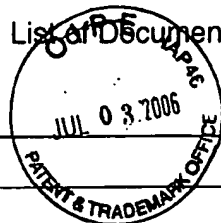
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